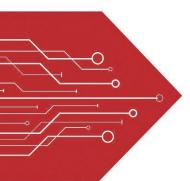
# MSKSEMI















**ESD** 

TVS

**TSS** 

MOV

**GDT** 

**PLED** 

Broduct data sheet

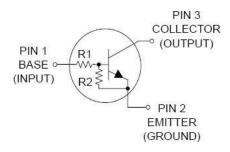
www.msksemi.com





SOT-523

## **Electrical Symbol:**



# Features:

- Simplifies Circuit Design
- Reduces Board Space
- Reduces Component Count
- RoHS Compliant
- Green EMC
- Matte Tin(Sn) Lead Finish
- Weight: approx. 0.002g

Absolute Maximum Ratings (T<sub>A</sub> = 25°C unless otherwise noted)

Symbol	Parameter	Value	Units
V <sub>СВО</sub>	Collector-Base Voltage	50	V
V <sub>CEO</sub>	Collector-Emitter Voltage	50	V
lc	Collector Current	100	mA
P <sub>D</sub>	Power Dissipation	150	mW
$R_{\theta JA}$	Thermal Resistance from Junction to Ambient	600	°C /W
T <sub>J</sub> T <sub>STG</sub>	Junction & Storage Temperature Range	-55 to +150	°C

These ratings are limiting values above which the serviceability of the device may be impaired.



#### **Device Marking & Resistor Values:**

P/N	Mark	R1 (KΩ)	R2 (KΩ)
DTC114EE-MS	24	10	10
DTC124EE-MS	25	22	22
DTC144EE-MS	26	47	47
DTC114YE-MS	64	10	47
DTC114TE-MS	04	10	$\infty$
DTC143TE-MS	03	4.7	∞
DTC123EE-MS	22	2.2	2.2
DTC143EE-MS	23	4.7	4.7
DTC143ZE-MS	E23	4.7	47
DTC124XE-MS	45	22	47
DTC123JE-MS	E42	2.2	47

## **Electrical Characteristics** (T<sub>A</sub> = 25°C unless otherwise noted)

## **Off Characteristics**

Symbol	Parameter	Test Condition	Limits			Unit
Symbol	raiailletei	rest condition	Min	Тур	Max	Ullit
Ісво	Collector-Base Cutoff Current	V <sub>CB</sub> =50V, I <sub>E</sub> =0A	-	-	100	nA
Iceo	Collector-Emitter Cutoff Current	V <sub>CE</sub> =50V, I <sub>B</sub> =0A	-	-	500	nA
I <sub>EBO</sub>	Emitter-Base Cutoff Current	V <sub>EB</sub> =6.0V, I <sub>C</sub> =0A				
	DTC114EE-MS		-	-	0.50	
	DTC124EE-MS		-	-	0.20	
	DTC144EE-MS		-	-	0.10	
	DTC114YE-MS		-	-	0.20	
	DTC114TE-MS		-	-	0.90	
	DTC143TE-MS		-	-	1.90	mA
	DTC123EE-MS		-	-	2.30	
	DTC143EE-MS		-	-	1.50	
	DTC143ZE-MS		-	-	0.18	
	DTC124XE-MS		-	-	0.13	
	DTC123JE-MS		-	-	0.20	
V <sub>(BR)CBO</sub>	Collector-Base Breakdown Voltage	I <sub>C</sub> =10uA, I <sub>E</sub> =0A	50	-	-	Volts
V <sub>(BR)CEO</sub>	Collector-Emitter Breakdown Voltage (Note 1)	I <sub>C</sub> =2.0mA, I <sub>B</sub> =0A	50	-	-	Volts

Note 1: Pulse Test. Pulse width <300us, Duty cycle < 2.0%)



# On Characteristics (Note 1)

Cumah al	Baramatar	Took Condition		Limits	Limits		
Symbol	Parameter	Test Condition	Min	Тур	Max	Unit	
H <sub>FE</sub>	DC Current Dain	V <sub>CE</sub> =10V, I <sub>C</sub> =5.0mA					
	DTC114EE-MS		35	60			
	DTC124EE-MS		60	100			
	DTC144EE-MS		80	140			
	DTC114YE-MS		80	140			
	DTC114TE-MS		160	350			
	DTC143TE-MS		160	350			
	DTC123EE-MS		8.0	15			
	DTC143EE-MS		15	30			
	DTC143ZE-MS		80	200			
	DTC124XE-MS		80	150			
	DTC123JE-MS		80	140			
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage						
	DTC114EE-MS	I <sub>C</sub> =10mA, I <sub>B</sub> =0.3mA					
	DTC124EE-MS	I <sub>C</sub> =10mA, I <sub>B</sub> =0.3mA					
	DTC144EE-MS	I <sub>C</sub> =10mA, I <sub>B</sub> =0.3mA					
	DTC114YE-MS	I <sub>C</sub> =10mA, I <sub>B</sub> =0.3mA					
	DTC114TE-MS	I <sub>C</sub> =10mA, I <sub>B</sub> =1mA			0.25	Volts	
	DTC143TE-MS	I <sub>C</sub> =10mA, I <sub>B</sub> =1mA			0.20	Volto	
	DTC123EE-MS	I <sub>C</sub> =10mA, I <sub>B</sub> =5mA					
	DTC143EE-MS	I <sub>C</sub> =10mA, I <sub>B</sub> =1mA					
	DTC143ZE-MS	I <sub>C</sub> =10mA, I <sub>B</sub> =1mA					
	DTC124XE-MS	I <sub>C</sub> =10mA, I <sub>B</sub> =1mA					
	DTC123JE-MS	I <sub>C</sub> =10mA, I <sub>B</sub> =0.3mA					
$V_{OL}$	Output Voltage (on)	R <sub>L</sub> = 1.0KΩ					
	DTC114EE-MS	V <sub>CC</sub> =5.0V, V <sub>B</sub> =2.5V					
	DTC124EE-MS	V <sub>CC</sub> =5.0V, V <sub>B</sub> =2.5V					
	DTC144EE-MS	V <sub>CC</sub> =5.0V, V <sub>B</sub> =3.5V					
	DTC114YE-MS	V <sub>CC</sub> =5.0V, V <sub>B</sub> =2.5V					
	DTC114TE-MS	V <sub>CC</sub> =5.0V, V <sub>B</sub> =2.5V			0.20	Volts	
	DTC143TE-MS	V <sub>CC</sub> =5.0V, V <sub>B</sub> =2.5V			5.20		
	DTC123EEMS	V <sub>CC</sub> =5.0V, V <sub>B</sub> =2.5V					
	DTC143EEMS	V <sub>CC</sub> =5.0V, V <sub>B</sub> =2.5V					
	DTC143ZEMS	V <sub>CC</sub> =5.0V, V <sub>B</sub> =2.5V					
	DTC124XEMS	V <sub>CC</sub> =5.0V, V <sub>B</sub> =2.5V					
	DTC123JEMS	V <sub>CC</sub> =5.0V, V <sub>B</sub> =2.5V					

#### On Characteristics

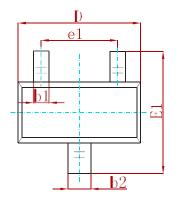
Cumbal	hal Darameter Test Condition	Took Condition		Limits		11:4
Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
V <sub>OH</sub>	Output Voltage (on)	R <sub>L</sub> = 1.0KΩ				
	DTC114EE-MS	V <sub>CC</sub> =5.0V, V <sub>B</sub> =0.5V				
	DTC124EE-MS	V <sub>CC</sub> =5.0V, V <sub>B</sub> =0.5V				
	DTC144EE-MS	V <sub>CC</sub> =5.0V, V <sub>B</sub> =0.5V				
	DTC114YE-MS	V <sub>CC</sub> =5.0V, V <sub>B</sub> =0.5V				
	DTC114TE-MS	V <sub>CC</sub> =5.0V, V <sub>B</sub> =0.25V	4.9			Volta
	DTC143TE-MS	V <sub>CC</sub> =5.0V, V <sub>B</sub> =0.25V	4.9			Volts
	DTC123EE-MS	V <sub>CC</sub> =5.0V, V <sub>B</sub> =0.5V				
	DTC143EE-MS	V <sub>CC</sub> =5.0V, V <sub>B</sub> =0.5V				
	DTC143ZE-MS	V <sub>CC</sub> =5.0V, V <sub>B</sub> =0.25V				
	DTC124XE-MS	V <sub>CC</sub> =5.0V, V <sub>B</sub> =0.5V				
	DTC123JE-MS	V <sub>CC</sub> =5.0V, V <sub>B</sub> =0.5V				

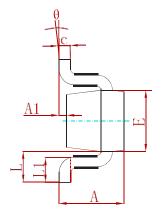
# **Electrical Characteristics** (T<sub>A</sub> = 25°C unless otherwise noted)

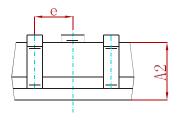
Symbol	Characteristic		Min	Тур	Max	Unit
R1	Input Resistor	DTC114EEMS	7.0	10	13	
		DTC124EE-MS	15.4	22	28.6	
		DTC144EE-MS	32.9	47	61.1	
		DTC114YE-MS	7.0	10	13	
		DTC114TE-MS	7.0	10	13	
		DTC143TE-MS	3.3	4.7	6.1	ΚΩ
		DTC123EE-MS	1.5	2.2	2.9	
		DTC143EE-MS	3.3	4.7	6.1	
		DTC143ZE-MS	3.3	4.7	6.1	
		DTC124XE-MS	15.4	22	28.6	
		DTC123JE-MS	1.54	2.2	2.86	
R1/R2	Resistor Ratio	DTC114EE-MS	0.8	1.0	1.2	
		DTC124EE-MS	0.8	1.0	1.2	
		DTC144EE-MS	0.8	1.0	1.2	
		DTC114YE-MS	0.17	0.21	0.25	
		DTC114TE-MS	-	-	-	
		DTC143TE-MS	-	-	-	
		DTC123EE-MS	0.8	1.0	1.2	
		DTC143EE-MS	0.8	1.0	1.2	
		DTC143ZE-MS	0.055	0.1	0.185	
		DTC124XE-MS	0.38	0.47	0.56	
		DTC123JE-MS	0.038	0.047	0.056	



## **PACKAGE MECHANICAL DATA**

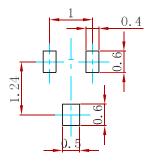






Cumbal	Dimensions	Dimensions In Millimeters		s In Inches	
Symbol	Min. Max.		Min.	Max.	
Α	0.700	0.900	0.028	0.035	
A1	0.000	0.100	0.000	0.004	
A2	0.700	0.800	0.028	0.031	
b1	0.150	0.250	0.006	0.010	
b2	0.250	0.350	0.010	0.014	
С	0.100	0.200	0.004	0.008	
D	1.500	1.700	0.059	0.067	
E	0.700	0.900	0.028	0.035	
E1	1.450	1.750	0.057	0.069	
е	0.500	TYP.	0.020	TYP.	
e1	0.900	1.100	0.035	0.043	
L	0.400	REF.	0.016	REF.	
L1	0.260	0.460	0.010	0.018	
0	0°	8°	0°	8°	

# **Suggested Pad Layout**



#### Note:

- 1.Controlling dimension:in millimeters.
- 2.General tolerance:±0.05mm.
- 3. The pad layout is for reference purposes only.

# **REEL SPECIFICATION**

P/N	PKG	QTY
DTCXXXXX-MS	SOT-523	3000



# **Attention**

- Any and all MSKSEMI Semiconductor products described or contained herein do not have specifications that can handle applications that require extremely high levels of reliability, such as life-support systems, aircraft's control systems, or other applications whose failure can be reasonably expected to result in serious physical and/or material damage. Consult with your MSKSEMI Semiconductor representative nearest you before using any MSKSEMI Semiconductor products described or contained herein in such applications.
- MSKSEMI Semiconductor assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all MSKSEMI Semiconductor products described or contained herein.
- Specifications of any and all MSKSEMI Semiconductor products described or contained herein stipulate the performance, characteristics, and functions of the described products in the independent state, and are not guarantees of the performance, characteristics, and functions of the described products as mounted in the customer's products or equipment. To verify symptoms and states that cannot be evaluated in an independent device, the customer should always evaluate and test devices mounted in the customer'sproducts or equipment.
- MSKSEMI Semiconductor. strives to supply high-quality high-reliability products. However, any and all semiconductor products fail with someprobability. It is possiblethat these probabilistic failures could give rise to accidents or events that could endanger human lives, that could give rise to smoke or fire, or that could cause damage to other property. When designing equipment, adopt safety measures so that these kinds of accidents or events cannot occur. Such measures include but are not limited to protective circuits anderror prevention circuitsfor safedesign, redundant design, and structural design.
- In the event that any or all MSKSEMI Semiconductor products(including technical data, services) described or contained herein are controlled under any of applicable local export control laws and regulations, such products must not be exported without obtaining the export license from theauthorities concerned in accordance with the above law.
- No part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanical, including photocopying and recording, or any information storage or retrieval system, or otherwise, without the prior written permission of MSKSEMI Semiconductor.
- Information (including circuit diagrams and circuit parameters) herein is for example only; it is not guaranteed for volume production. MSKSEMI Semiconductor believes information herein is accurate and reliable, but no guarantees are made or implied regarding its use or any infringementsof intellectual property rights or other rightsof third parties.
- Any and all information described or contained herein are subject to change without notice due to product/technology improvement, etc. Whendesigning equipment, referto the "Delivery Specification" for the MSKSEMI Semiconductor productthat you intend to use.

# 单击下面可查看定价,库存,交付和生命周期等信息

# >>MSKSEMI (美森科)